DATA SHEET

S6EXK0030-574

BEAMEXPANDER
MAGNIFICATION 3.0
FOR 343 - 355 nm
FUSED SILICA

OUTLINE DRAWING
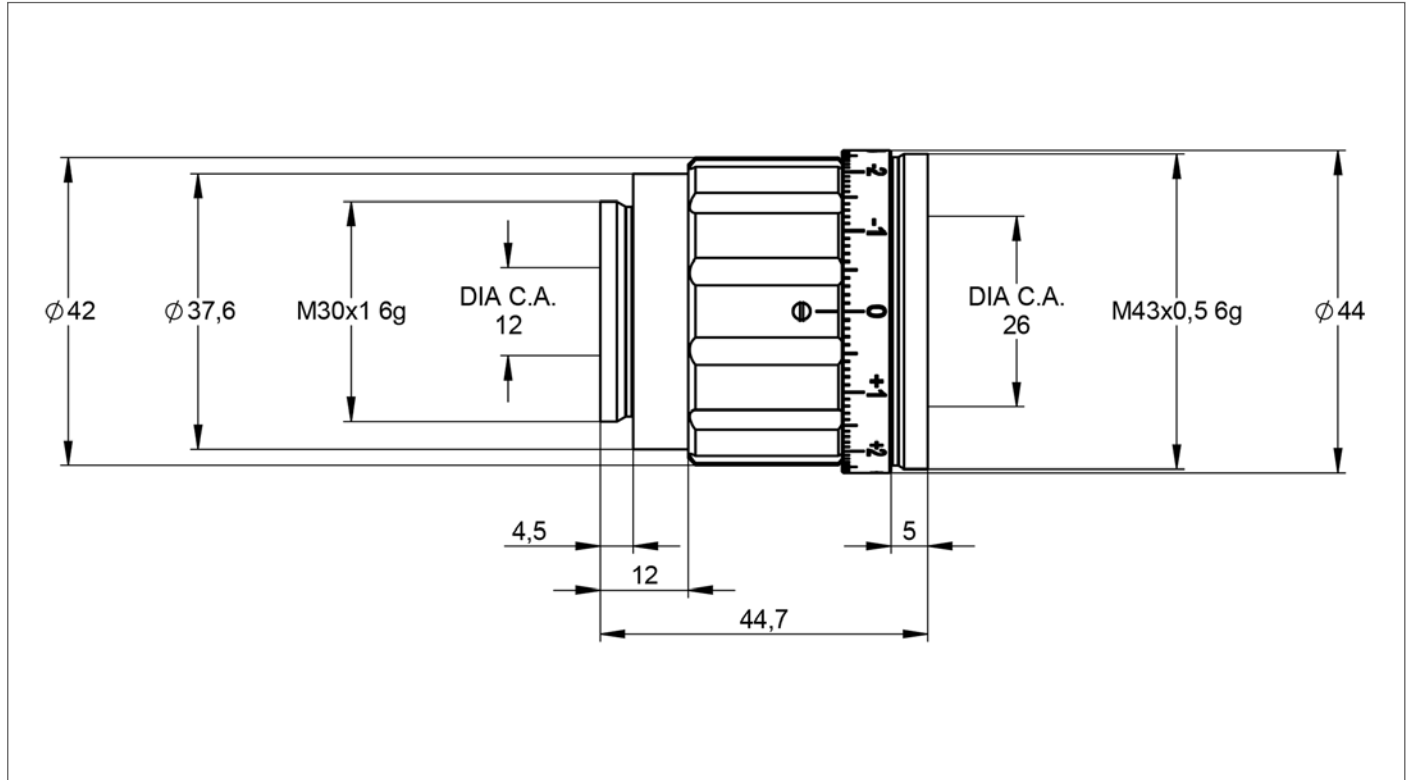
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SPECIFICATIONS

article number	S6EXK0030-574
design wavelength [nm]	355
magnification factor	3.0
divergence adjustable	yes
optical principle	Galilei (no internal focus)
pointing stability [mrad]	< 1
clear input aperture [mm]	8.0
clear output aperture [mm]	26.0
recommended beam-Ø [mm][1]	2.0
total number of lenses	2
total transmission [%]	> 99
lens material	fused silica
LIDT (coating) [J/cm²]	1.0 J/cm² per 1ns pulse at 50Hz
SP and USP usable	yes
SP and USP usable, reversed usage	yes
mounting thread	M30x1
weight [kg]	0.2
accessory	S6MEC0107 - adapter M30x1 to C-mount

DIVERGENCE ADJUSTMENT

entrance lens · exit lens · divergence adjustment · convergent · divergent

MOUNTING POSITIONS


M30x1 · M43x0.5 · recommended mounting position
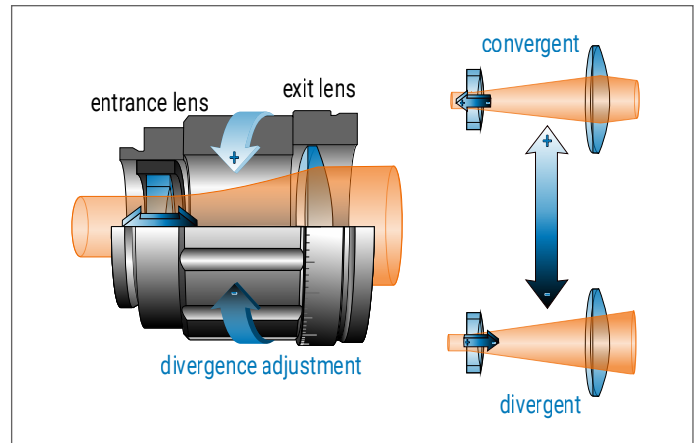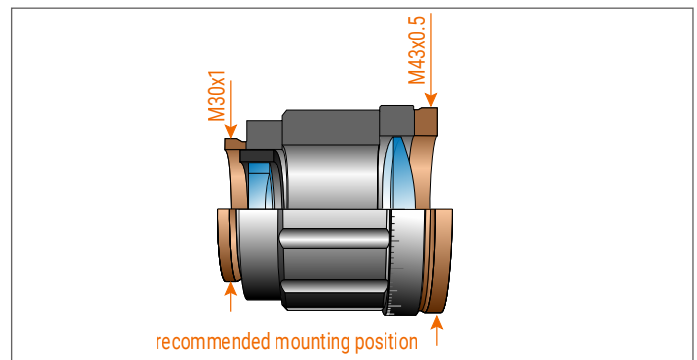
REMARKS

[1] clipped at 1/e²; wavefront error on axis (PV) < λ/10 (value provided by design)
magnification (reversed mode) = 1 / magnification (regular mode)
divergence adjustement = 0 → collimated input beam results in collimated output beam
maximum divergence adjustment is ± 3 mm
RoHS compliant
length at divergence setting „0" stated in the drawing - length extension of max. 3 mm is possible

BACK REFLECTION POSITION

back reflections [mm]
18.6
back reflections reverse [mm]
15.18
0.00
0.00

± 3 mm · ± 3 mm · back reflection position · back reflection position reversed mode (for beam reduction)

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